

Applicat	tion/Control No.	Applicant(s)/Pate Reexamination	ent under
10/501,	049	KOKKONEN, M	IKKO
Examine	er	Art Unit	
TED M.	WANG	2611	

SEARCHED						
Class	Subclass	Date	Examiner			

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST - USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB, see attached search report	1/15/2009	TW
ODP- serached and reviewed from PALM and EAST	1/15/2009	TW
IEEExplor- Advance - (MIMO or MISO) and first estimat* and second estimat* and independent	1/15/2009	TW
IEEExplor - Author -Kokkonen M.	1/15/2009	TW